产品信息

MarSurf CD 140 AF Contour measuring station

产品特性

MarSurf CD 140 AF - Spaceoptimized measuring station for production

With the new MarSurf CD 140 AF, Mahr has launched a new contour measuring device onto the market. Its probe system has a measuring range of up to 70 mm, with which the probe tips can be changed quickly and without tools # and all without recalibration.

MarSurf CD 140 AF makes fast and precise measurements possible. Thanks to its flexible workpiece holder, it is particularly easy to handle and impresses with its great 物品号: **6269053** versatility.



技术数据

| at 111-de | | | |
|-------------------------------|------------------------------------|--|--|
| 分辨率 | 20 nm | | |
| 测量力 (N) | 4 mN to 30 mN, software adjustable | | |
| 测量速度 | 0.1 mm/s 到 10 mm/s | | |
| Positioning speed X-axis min. | 0.1 mm/s | | |
| positioning speed X-axis max. | 200 mm/s | | |
| 定位速度 (mm/s), X 轴 | 0.1 - 200 mm/s | | |
| 测头 | Contour tracing system | | |
| 重量(毛重) | 35 KG | | |
| Workpiece weight max. | 1.5 kg | | |
| 其他 | machine weight: 35 kg | | |
| 测量范围 mm | 70 mm with probe arm length 350 mm | | |

附件

| 订单号 | 标识 | 产品型号 |
|---------|------|------|
| 6710401 | ∨ 形块 | PP |